

**Notice of References Cited**

Application/Control No.

10/007,421

Applicant(s)/Patent Under  
Reexamination  
MATSUMOTO ET AL.

Examiner

Yewebdar T Tadesse

Art Unit

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,015,524	05-1991	Kobayashi et al.	428/332
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP- 2002-182010	12-2002	Japan		
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English Translation Abstract of JP-2002-182010
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.